

Power MOSFET

1A, 650V N-CHANNEL SUPER-JUNCTION MOSFET

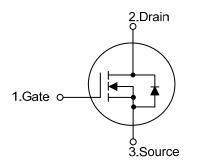
DESCRIPTION

The UTC 1NM65-FD is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

FEATURES

- * R_{DS(ON)} < 4.6Ω @ V_{GS}=10V, I_D=0.5A
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL



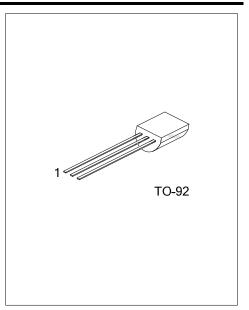
ORDERING INFORMATION

Ordering Number		Daakaga	Pin	Assignn	Decking		
Lead Free	Halogen Free	Package	1	2	3	Packing	
1NM65L-T92-B	1NM65G-T92-B	TO-92	G	D	S	Tape Box	
1NM65L-T92-K	1NM65G-T92-K	TO-92	G	D	S	Bulk	

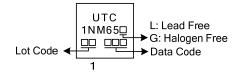
Note: Pin Assignment: G: Gate D: Drain S: Source

1NM65 <u>G-Т92-В</u>	(1)Packing Type (2)Package Type (3)Green Package	(1) B: Tape Box, K: Bulk (2) T92: TO-92 (3) G: Halogen Free and Lead Free, L: Lead Free					
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MARKING





Power MOSFET

■ **ABSOLUTE MAXIMUM RATINGS** (T_c=25°C, unless otherwise specified)

PARAMETE	R	SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V _{DSS}	650	V	
Gate-Source Voltage		V _{GSS}	±30	V	
Continuous Drain Current		Ι _D	1.0	А	
Pulsed Drain Current (Note 2)		I _{DM}	3.0	А	
Avalanche Energy (Note 3)	Single Pulsed	E _{AS}	9.0	mJ	
Peak Diode Recovery dv/dt (No	ote 4)	dv/dt	10	V/ns	
Power Dissipation		PD	1.42	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L=10mH, I_{AS}=1.3A, V_{DD}=50V, R_G=25 Ω , Starting T_J = 25°C

4. $I_{SD} \le 1.0A$, di/dt $\le 200A/\mu$ s, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

THERMAL DATA

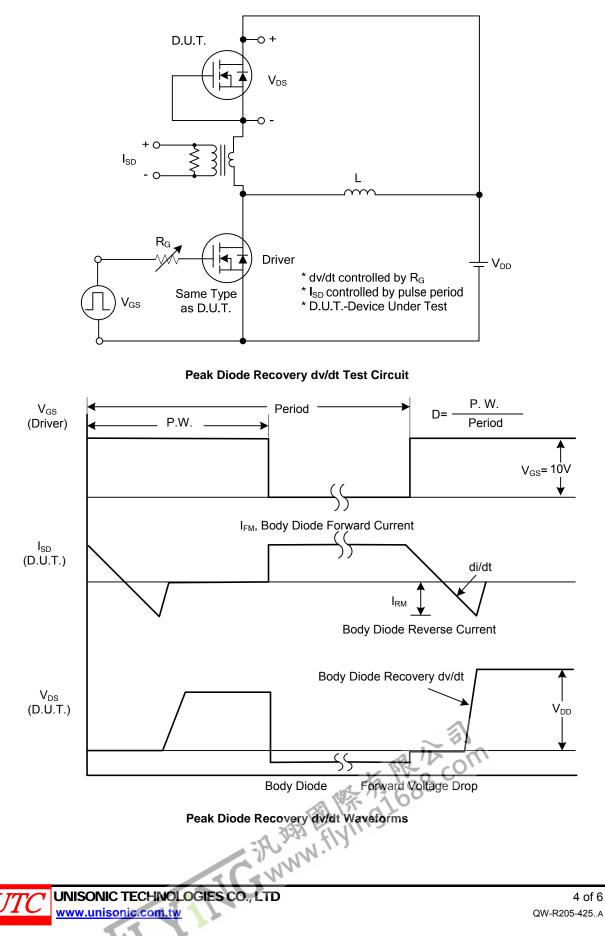
PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	180	°C/W
Junction to Case	θ _{JC}	88	°C/W

ELECTRICAL CHARACTERISTICS (T_c =25°C, unless otherwise specified)

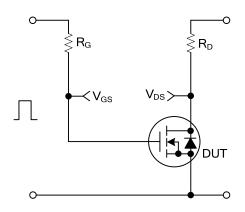
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} = 0V, I _D = 250µA	650			V		
Drain-Source Leakage Current		I _{DSS}	$V_{DS} = 650V, V_{GS} = 0V$			10	μA		
Cata Source Lookage Current	Forward	- I _{GSS}	$V_{GS} = 30V, V_{DS} = 0V$			100	nA		
Gate-Source Leakage Current	Reverse		V_{GS} = -30V, V_{DS} = 0V			-100	nA		
ON CHARACTERISTICS									
Gate Threshold Voltage		V _{GS(TH)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$ 2.5			4.5	V		
Static Drain-Source On-State Res	istance	R _{DS(ON)}	V _{GS} = 10V, I _D =0.5A			4.6	Ω		
DYNAMIC CHARACTERISTICS									
Input Capacitance		C _{ISS}			115		рF		
Output Capacitance		C _{OSS}	V _{DS} =25V, V _{GS} =0V, f =1MHz		105		рF		
Reverse Transfer Capacitance		C _{RSS}			10		рF		
SWITCHING CHARACTERISTIC	S						-		
Total Gate Charge		Q_{G}	V _{DS} =100V, V _{GS} =10V,		11		nC		
Gate-Source Charge		Q_{GS}	I _D =1A, I _G =3mA (Note 1, 2)		5		nC		
Gate-Drain Charge		Q_{GD}			2.2		nC		
Turn-On Delay Time		t _{D (ON)}			0.8		ns		
Turn-On Rise Time		t _R	$V_{DD} = 50V, V_{GS} = 10V, I_D = 1A,$ $R_G = 25\Omega$ (Note 1, 2)		3.4		ns		
Turn-Off Delay Time		t _{D(OFF)}			17.6		ns		
Turn-Off Fall Time		t _F			48		ns		
DRAIN-SOURCE DIODE CHARA	CTERISTIC	CS							
Maximum Body-Diode Continuous	Current	Is		0		1.0	Α		
Continuous Drain-Source Current		I _{SD}	NR COV			3.0	Α		
Drain-Source Diode Forward Voltage		V _{SD}	I _S =1.0A, V _{GS} =0V			1.4	V		
Reverse Recovery Time		t _{rr}	I _F =1.0A, ∀ _{DD} =100V		84		ns		
Reverse Recovery Charge		Q _{rr}	di/dt = 100A/µs		0.25		μC		
Notes: 1. Pulse Test: Pulse width	≤ 300µs, D	uty cycle≤2%.	1/13						

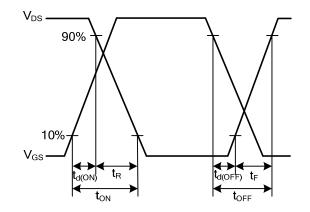
2. Essentially independent of operating temperature

TEST CIRCUITS AND WAVEFORMS

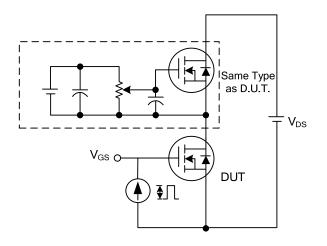


TEST CIRCUITS AND WAVEFORMS (Cont.)

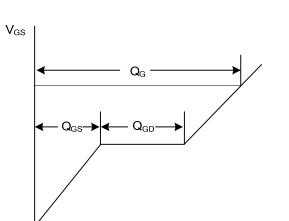




itching Test Circuit



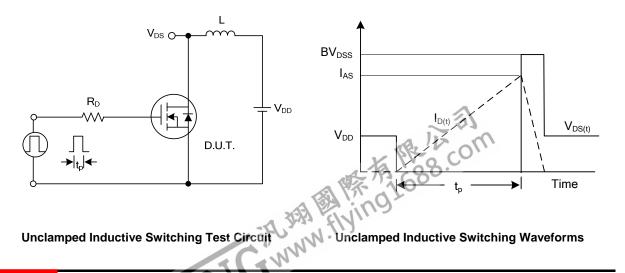
Gate Charge Test Circuit



Switching Waveforms



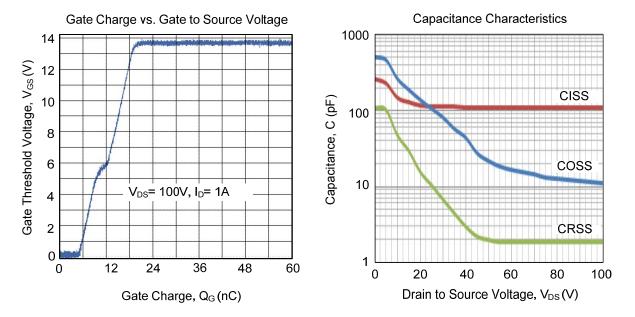
Gate Charge Waveform



Unclamped Inductive Switching Waveforms

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TYPICAL CHARACTERISTICS



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